


<b>Search Notes</b> 	<b>Application/Control No.</b> 10007611	<b>Applicant(s)/Patent Under Reexamination</b> KODAMA, MEI
	<b>Examiner</b> Tran, Hai	<b>Art Unit</b> 2623

SEARCHED			
Class	Subclass	Date	Examiner
725	92	02/02/2007	HVT
349	478	02/02/2007	HVT
382	317	02/02/2007	HVT

SEARCH NOTES		
Search Notes	Date	Examiner
Scott Beliveau-725	02/02/2007	HVT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner